

<b>Notice of References Cited</b>	Application/Control No. 10/790,774	Applicant(s)/Patent Under Reexamination MARUYAMA ET AL.	
	Examiner TUAN C. TO	Art Unit 3663	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0045996	03-2003	Yamazaki et al.	701/200
*	B	US-6,970,786	11-2005	Hayama et al.	701/209
*	C	US-2003/0055559	03-2003	Kuroda et al.	701/208
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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